



P-Channel 30 V (D-S) MOSFET with Schottky Diode

MOSFET PRODUCT SUMMARY					
V _{DS} (V)	$V_{DS}(V)$ $R_{DS(on)}(\Omega)$		Q _g (Typ.)		
- 30	0.068 at V _{GS} = - 10 V	- 4.6	4.6		
	0.110 at V _{GS} = - 4.5 V	- 3.4	4.0		

SCHOTTKY PRODUCT SUMMARY				
V _{KA} (V)	V _F (V) Diode Forward Voltage	I _D (A) ^a		
30	0.44 V at 1 A	2		

FEATURES

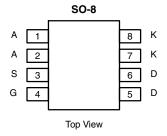
- Halogen-free According to IEC 61249-2-21 **Definition**
- LITTLE FOOT® Plus Power MOSFET
- 100 % R_q Tested
- Compliant to RoHS Directive 2002/95/EC



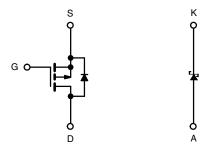
HALOGEN FREE

APPLICATIONS

- Battery Management in Notebook PC
- Non-synchronous Buck Converter in HDD



Ordering Information: Si4833BDY-T1-GE3 (Lead (Pb)-free and Halogen-free)



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $(T_A = 25)$	°C, unless ot	herwise noted)		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage (MOSFET)	V_{DS}	- 30			
Reverse Voltage (Schottky)	V_{KA}	- 30	V		
Gate-Source Voltage (MOSFET)		V_{GS}	± 20		
		- 4.6			
Continuous Drain Current (T _J = 150 °C) (MOSFET)	T _C = 70 °C	l _D	- 3.6		
	T _A = 25 °C	- I _D -	- 3.8 ^{b, c}		
	T _A = 70 °C		- 3 ^{b, c}		
Pulsed Drain Current (MOSFET) (t = 300 μs)		I _{DM}	- 20	Α	
Continuous Source Current (MOSFET Diode Conduction)		I _S	- 2		
Continuous Source Current (MOSI ET Diode Conduction)	T _A = 25 °C	'5	- 1.4 ^{b, c}		
Average Forward Current (Schottky)	I _F	- 1.4 ^b			
Pulsed Forward Current (Schottky)	I _{FM}	- 2			
	T _C = 25 °C	. P _D	2.75		
Manipular Device District (MOOFFT and Oak aller)	T _C = 70 °C		1.75	W	
Maximum Power Dissipation (MOSFET and Schottky)	T _A = 25 °C		1.75 ^{b, c}	VV	
	T _A = 70 °C		1.10 ^{b, c}		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS					
Parameter	Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient (MOSFET and Schottky) ^{b, c, d}	R _{thJA}	60	71.5	°C/W	
Maximum Junction-to-Foot (Drain) (MOSFET and Schottky)	R _{thJF}	35	45	0/11	

- a. Based on $T_C = 25$ °C.
- b. Surface mounted on FR4 board.
- d. Maximum under steady state conditions is 120 °C/W.



MOSFET SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{DS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS/TJ}$	I _D = - 250 μA		- 20		m)//°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)/TJ}$	η _D = - 250 μΑ		3.9		mV/°C	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1	- 1.8	- 2.5	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
7 0		V _{DS} = - 30 V, V _{GS} = 0 V			- 1		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 75 \text{ °C}$			- 10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 5			Α	
	В	V _{GS} = - 10 V, I _D = - 3.6 A		0.055	0.068		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 2.8 A		0.092	0.110	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 3.6 A		6.5		S	
Dynamic ^b			L	<u> </u>	l	L	
Input Capacitance	C _{iss}			350			
Output Capacitance	C _{oss}	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		75		pF	
Reverse Transfer Capacitance	C _{rss}			63			
Total Gate Charge	Q _g	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -5 \text{ A}$		9	14	nC	
Total date offarge				4.6	7		
Gate-Source Charge	Q_{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -5 \text{ A}$		1.3		110	
Gate-Drain Charge	Q_{gd}			2.1			
Gate Resistance	R_{g}	f = 1 MHz	1.5	7.3	14.5	Ω	
Turn-On Delay Time	t _{d(on)}			28	50		
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_L = 3 \Omega$		73	140		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -5 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		12	24		
Fall Time	t _f			8	16	ns	
Turn-On Delay Time	t _{d(on)}			6	12	113	
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_L = 3 \Omega$		9	18		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 5 A, V_{GEN} = - 10 V, R_g = 1 Ω		12	24		
Fall Time	t _f			6	12		
Drain-Source Body Diode Characteristic	cs						
Continous Source-Drain Diode Current	I _S	T _C = 25 °C			- 4.6	_	
Pulse Diode Forward Current ^a	I _{SM}				- 20	_ A	
Body Diode Voltage	V _{SD}	I _S = -2 A, V _{GS} = 0 V		- 0.83	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			12	24	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 2 A, dl/dt = 100 A/μs, T _J = 25 °C		6	12	nC	
Reverse Recovery Fall Time	t _a	$\frac{1}{1}$ $\frac{1}$		8			
Reverse Recovery Rise Time	t _b			4		ns	
	•		•	•	•		

a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

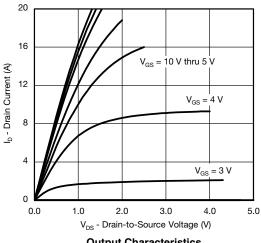




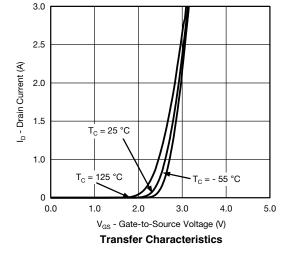
SCHOTTKY SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Forward Voltage Drop	V _F	I _F = 1 A		0.36	0.44	V	
Forward Voltage Drop		I _F = 1 A, T _J = 125 °C		0.29	0.35	v	
	I _{rm}	V _R = 30 V		0.03	0.2		
Maximum Reverse Leakage Current		V _R = 30 V, T _J = 75 °C		0.6	5	mA	
		V _R = 30 V, T _J = 125 °C		7.5	60		
Junction Capacitance	C _T	V _R = 15 V		5.3		pF	

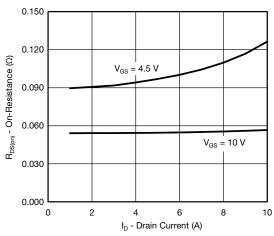
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

MOSFET TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







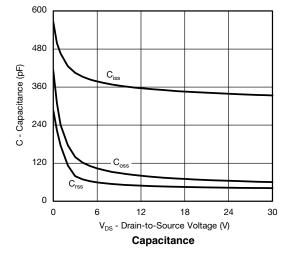


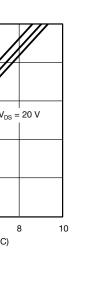
On-Resistance vs. Drain Current and Gate Voltage

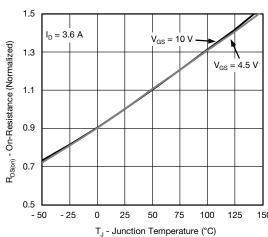
6

Q_g - Total Gate Charge (nC)

Gate Charge







On-Resistance vs. Junction Temperature

10

8

6

4

2

0

0

2

V_{GS} - Gate-to-Source Voltage (V)

I_D = 5 A

 $I_{D} = 3.6 A$

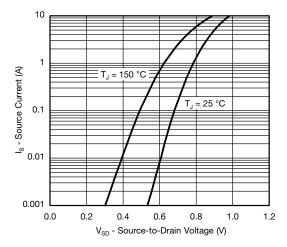
T_J = 125 °C

T_J = 25 °C

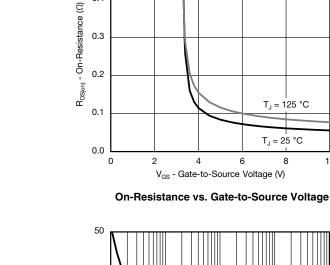
10



MOSFET TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



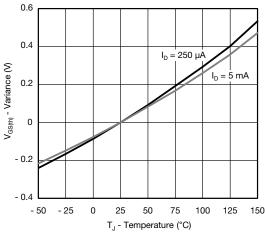
Source-Drain Diode Forward Voltage



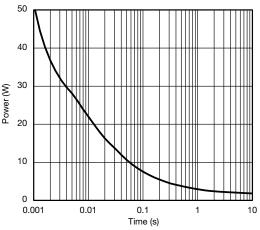
2

0.5

0.4

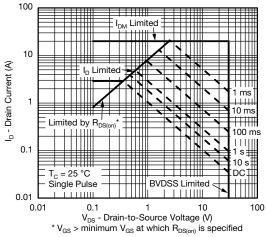


Threshold Voltage



 V_{GS} - Gate-to-Source Voltage (V)

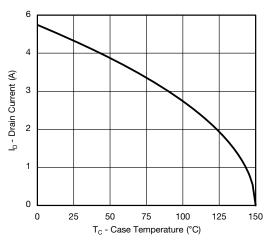
Single Pulse Power, Junction-to-Ambient



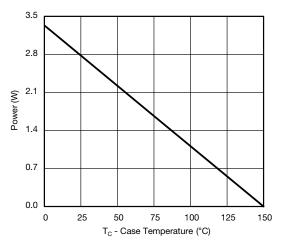
Safe Operating Area, Junction-to-Case



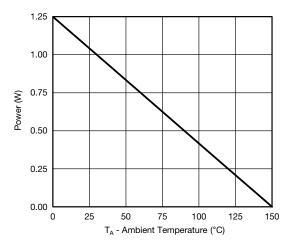
MOSFET TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*



Power Derating, Junction-to-Foot

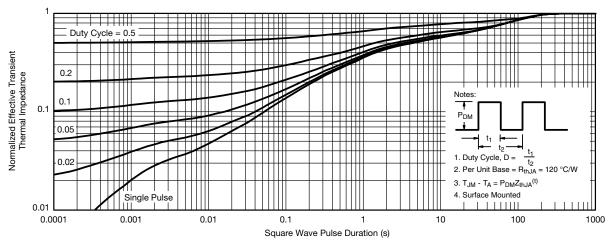


Power Derating, Junction-to-Ambient

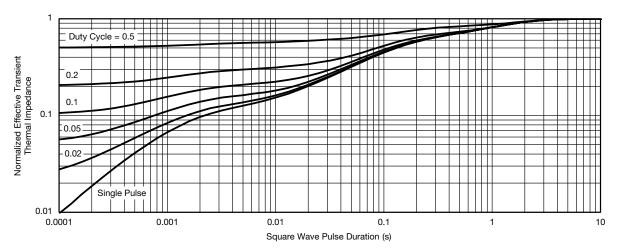
 $^{^*}$ The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



MOSFETS TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

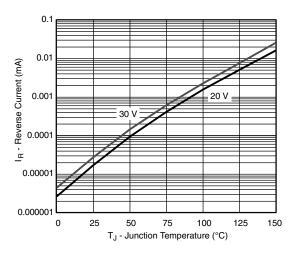


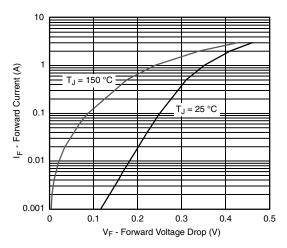
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

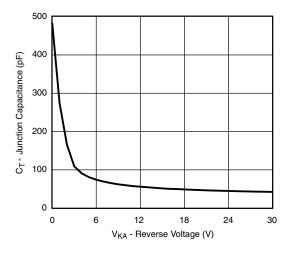
SCHOTTKY TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Reverse Current vs. Junction Temperature

Forward Voltage Drop



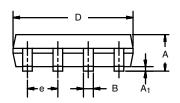
Capacitance

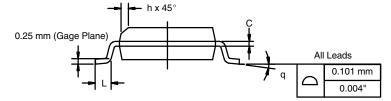
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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	MILLIMETERS INCHES				
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27 BSC		0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I. 11-Sep-06						

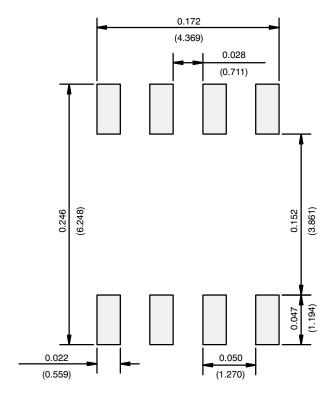
DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06

APPLICATION NOTE



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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